

# Search Notes



Application N .

10/647,811

Examiner

Sang Y Paik

Applicant(s)

GADOW ET AL.

Art Unit

3742

## SEARCHED

Class	Subclass	Date	Examiner
219	465.1 466.1 547		
	544 546		
	547 <del>548</del>		
501	126		
	127 128		
	132		
	87		
	89		
	97		
	94		
	102		
	103		
	108		
	153		
438	404 406		
	415 416		
	417		
	418	12/8/0	90
updated as above		12/6/04	18

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
295 TEST PATENTS Inventorship	12/8/04 12/6/04	28 18